

# Low temperature sensing of NO<sub>2</sub> gas using SnO<sub>2</sub>-ZnO nanocomposite sensor

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Received: 12 July 2012, Revised: 18 October 2012 and Accepted: 10 November 2012

## ABSTRACT

In the present work an effort has been made to synthesize nanocrystalline composites (NCC) of Zinc oxide and Tin oxide (ZSO) using chemical route for efficient sensing of NO<sub>2</sub> gas at lower operating temperature. The structural, microstructural and optical information have been revealed by X-ray diffraction (XRD), Atomic force microscopy (AFM) and UV-Visible spectroscopy respectively. Sensor structure showed a better sensing response ( $S \sim 6.64 \times 10^2$ ) at a relatively low operating temperature of 70 °C for 20 ppm NO<sub>2</sub> gas with an average response time of about 2 min. The sensing response characteristics for NO<sub>2</sub> gas has been compared with corresponding results obtained for pure SnO<sub>2</sub> and ZnO thin film based sensor structure. Copyright © 2013 VBRI press.

**Keywords:** SnO<sub>2</sub>; nanocomposites; NO<sub>2</sub> gas; thin film.



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Electro-optic applications, oxide nanostructures for multi functional applications etc.

## Introduction

Tin oxide has been widely used for various catalytic applications, gas sensing, transparent conducting electrodes and liquid crystal displays, etc. [1–5]. As an n-type semiconductor with a wide energy band gap, tin oxide spans a wide range of applications from conductive electrodes and transparent coatings, to heterojunction solar cells, and chemical sensors [6, 7]. SnO<sub>2</sub> possesses excellent capability of exchange of oxygen from the atmosphere due to natural non-stoichiometry, that makes it the most suitable material for gas sensing application. The adsorption/desorption of oxygen on the surface of SnO<sub>2</sub> is the key parameter for change in conductance. The adsorbed oxygen on the surface (or grain boundaries) of SnO<sub>2</sub> captures the free electrons and becomes O<sup>2-</sup>. It is important to point out that chemisorption of oxygen is crucial for gas sensing mechanism. Gas sensing properties depend on microstructure, impurities and size effect of crystallites. It is well-known that gas-sensing characteristics of SnO<sub>2</sub> can be dramatically altered by controlling the morphological and microstructural features such as particle size, shape, surface/volume ratio, and porosity. Recently nanostructures are reported to be advantageous for the gas sensing application due to their higher surface/volume ratio. SnO<sub>2</sub> nanoparticles have been reported to be prepared by using different chemical methods such as precipitation, hydrothermal, sol-gel, gel-combustion and spray pyrolysis [3–10]. Among them, sol-gel method has the advantage of low temperature processing and the surface is free from the O–H groups, which affects its properties [6, 8]. SnO<sub>2</sub> nanostructures have been found to be promising for gas sensors to detect gases such as NO, NO<sub>2</sub>, CO, H<sub>2</sub>S, C<sub>2</sub>H<sub>5</sub>OH etc. [11–15] however, the sensors based on SnO<sub>2</sub> nanostructures demand higher operating temperatures. On the other hand, the practical on field gas sensors demand room temperatures operating sensors with enhanced response characteristics for trace level detection of harmful gases. ZnO is another material utilized for the fabrication of gas sensors; however, their sensing response is not so promising though the operating temperatures are low. Hence, a composite structure of SnO<sub>2</sub> with ZnO may be beneficial in reducing the operating temperature with enhanced sensing response. NO<sub>2</sub> is the major cause of formation of ground-level ozone in the stratosphere, acid rains, and an active ingredient to global warming. Exposure to high concentrations of NO<sub>2</sub> can make living organisms more susceptible to bacterial infections and lung cancer. Just like other pollutants, nitrogen dioxide affects people with existing medical conditions more severely than healthy people. The available NO<sub>2</sub> sensors are operative at very high temperature (150–800 °C) with low sensing response (2–100) even in higher concentrations as shown in **Table 1** [16–25]. Efforts are continuing towards the development of NO<sub>2</sub> gas sensors aiming with enhanced response along with reduction in operating temperature by incorporating some catalysts or dopants as shown in **Table 1**. Thus in the present work an effort has been made to develop a SnO<sub>2</sub> nanoparticles doped with ZnO nanoparticles based gas sensor to detect trace level NO<sub>2</sub> gas at lower operating temperature.

**Table 1.** Literature survey on catalyst modified SnO<sub>2</sub> based NO<sub>2</sub> gas sensors.

| Material used                          | Method                       | Catalyst /doping               | Temp (°C) | Sensitivity (Concentration) | Response/ Recovery time | Reference |
|--|------------------------------|--------------------------------|-----------|-----------------------------|-------------------------|-----------|
| SnO <sub>2</sub> thin film             | Slide off transfer printing  | WO <sub>3</sub>                | 400       | 8 (100 ppm)                 | 20 sec / 80 sec         | 16        |
| SnO <sub>2</sub> thick film            | Chemical route               | Au                             | 300       | 3.5 (2000 ppb)              | 20 min/ 50 min          | 17        |
| SnO <sub>2</sub> thin film             | Sputtering                   | Mo                             | 270       | 20 (10 ppm)                 | -                       | 18        |
| SnO <sub>2</sub> thick film            | Screen Printing              | WO <sub>3</sub> -Au            | -         | 1 (10 ppm)                  | 2 min/ 3 min            | 19        |
| SnO <sub>2</sub> pellet heterojunction | Powder mixing (Ball milling) | WO <sub>3</sub>                | 300       | 6.5 (5 ppm)                 | -                       | 20        |
| SnO <sub>2</sub> nanowires             | Evaporation                  | Ru                             | 100       | 3500 (200 ppm)              | 100 sec/ 300 sec        | 21        |
| SnO <sub>2</sub> thin film             | Wet Chemical                 | Fe <sub>2</sub> O <sub>3</sub> | 170       | 110 (1000 ppm)              | 5 min/ 40 min           | 22        |
| SnO <sub>2</sub> thin film             | Sol gel                      | Indium                         | 150       | 72 (500 ppm)                | 2 sec/ 2 min            | 23        |
| SnO <sub>2</sub> nanofibres            | Pulse Laser Deposition       | ZnO                            | 180       | 100 (3.2 ppm)               | 4 min/ 8 min            | 24        |
| SnO <sub>2</sub> nanowires             | Two-Step Vapor Growth        | ZnO                            | 300       | 12.3 (10 ppm)               | 5 sec/ 12 sec           | 25        |

## Experimental

### Materials and methods

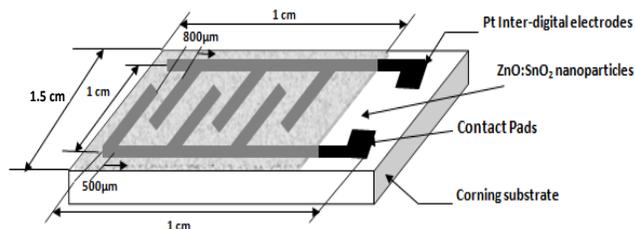
Tin (IV) chloride pentahydrate (SnCl<sub>4</sub>·5H<sub>2</sub>O), Isopropanol, propanol, Zinc acetate, Lithium Hydroxide, Ethanol and n-Butyl Acetate used for the sensor preparation were purchased from Sigma Aldrich Chemical Co. with 99.99% purity. A mixture of 12.37 g tin tetrachloride (SnCl<sub>4</sub>·5H<sub>2</sub>O 99.99%) with 15 g isopropanol was prepared. This is an exothermic reaction, hence the solution was cooled down to room temperature and 3.42 g water in 10 g propanol mixture was added for hydrolysis reaction forming the sol of SnO<sub>2</sub> nanoparticles.

0.01 M of Zinc acetate dihydrate was dissolved in the 75 ml of boiling ethanol (75 °C) in a round bottom flask fitted with a condenser at atmospheric pressure. The solution is refluxed at 75 °C for about 30 minutes and subsequently allowed to cool at room temperature to give a transparent and stable Zn based precursor. In another beaker, 0.014 M of lithium hydroxide monohydrate was dissolved in 50 ml of ethanol ultrasonically to accelerate the reaction at room temperature. A clear solution is obtained after sonication for about 25–30 min. The hydroxide containing solution was added drop wise to the acetate containing solution at room temperature under vigorous magnetic stirring, and finally a transparent ZnO sol is obtained after hydrolyzing the precursor.

The alcoholic solution of zinc acetate is heated at 75 °C to prepare an intermediate species through hydrolysis and condensation. The acetic acid produced during the heat treatment reacts with ethanol and results in the generation of additional water through an esterification process. The addition of LiOH to the transparent precursor leads to the formation of ZnO nanoparticle sol. The prepared ZnO nanoparticles were added into SnO<sub>2</sub> nanoparticle colloidal solution in the ratio of 60:40 (SnO<sub>2</sub>:ZnO). SnO<sub>2</sub> and ZnO:SnO<sub>2</sub> sol were used to deposit respective thin films on corning glass and inter digital electrode (IDEs)

patterned on corning glass substrates by spin coating. The samples were annealed at 500 °C for 1 hour in atmospheric air.

The sensing response characteristics of SnO<sub>2</sub> and ZnO:SnO<sub>2</sub> nanocomposite thin films were studied using the films deposited on IDE/glass substrates as shown in **Fig. 1**. The Pt IDEs were patterned over the corning glass substrates using conventional photolithography, prior to deposition of sensing layer (ZnO:SnO<sub>2</sub>) nanocomposite thin film). The platinum thin film of 90 nm thickness was deposited by RF sputtering using platinum metal target in 100% Ar. In order to improve the adhesion of Pt on corning glass substrate an ultra thin (10 nm) buffer layer of Titanium was sputtered prior to Pt deposition.



**Fig. 1.** Schematic of gas sensor structure.

### Characterization

Thickness and surface roughness of deposited thin films were measured using a Veeco Dektak 150 surface profiler. Crystalline structure and surface morphology of the sensing layer were studied using Bragg–Brentano ( $\theta$ – $2\theta$ ) scan of a X-ray Diffractometer (Bruker D8 Discover) using the CuK $\alpha$ 1 source ( $\lambda = 0.154$  nm) and Atomic force microscopy (Veeco DICP2) respectively. A Double Beam UV–visible Spectrophotometer (Perkin Elmer, Lambda 35) was used to study the optical properties of ZnO and SnO<sub>2</sub> thin films.

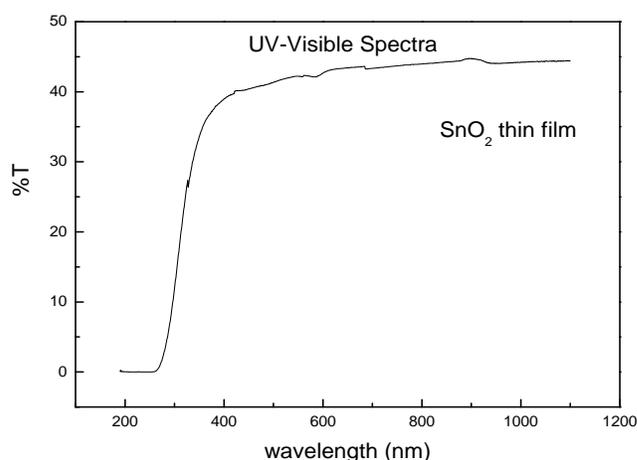
### Sensing test chamber

NO<sub>2</sub> gas sensing characteristics of sensors were studied in a specially designed “gas sensor test rig (GSTR)” having a glass test chamber. NO<sub>2</sub> gas was introduced into the glass test chamber using calibrated leaks through needle valves. A pirani gauge with a rotary pump was used to control the flow of target gas in the test chamber. Vacuum of the order of  $\sim 10^{-3}$  Torr was first created in the test chamber and subsequently a mixture of the known concentration of target gas and clean (dry synthetic) air was introduced till the test chamber acquired the atmospheric pressure to ensure that the target gas was free from any other disturbing gas. The creation of vacuum ensures the removal of any foreign gas molecules from the test chamber. The measurements were carried out in static mode. At the time of recovery of the sensor, target gas was flushed out of the test chamber (by creating vacuum again) and the clean dry air was introduced. The sensor was placed on a temperature controlled heating block inside the glass test chamber and spring loaded platinised contacts were used to measure the sensor response as a function of temperature (30–150 °C). At each temperature the sensor was first stabilized in air to obtain a stable resistance value. Target gas (NO<sub>2</sub>) of specific concentration was introduced into the test chamber

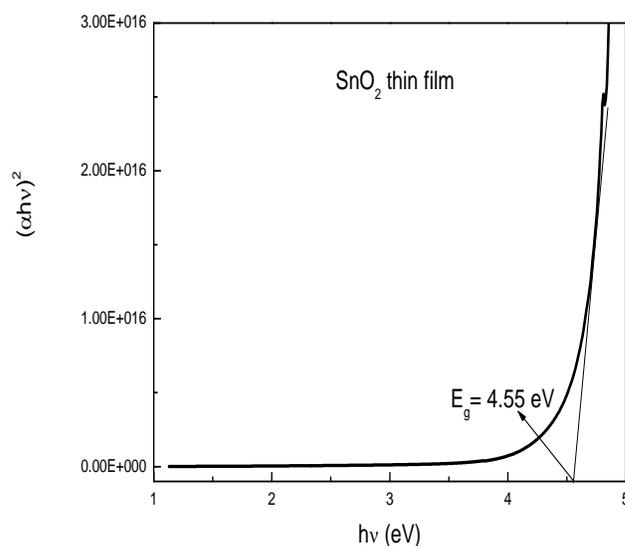
and changes in the sensor resistance were recorded after every second using a data acquisition system consisting of a digital multi-meter (Keithley 2700) interfaced with a computer. The sensor response for an oxidizing gas such as NO<sub>2</sub> is defined as:

$$S = (R_g - R_a) / R_a$$

where,  $R_a$  and  $R_g$  are the resistances of the sensor in the presence of atmospheric air and target gas respectively. The response time was measured as the time taken by the sensor to acquire the 90% of its maximum resistance value in the presence of target oxidizing gas. Once the maximum resistance value is attained, the target gas was flushed out of the test chamber and sensor was allowed to regain its initial resistance value in atmospheric air while keeping the sensor at the same temperature. Time taken by the sensor to reacquire about 10% higher value of its initial resistance in the presence of atmospheric air is considered as the recovery time.



**Fig. 2.** Transmittance spectra of SnO<sub>2</sub> thin film.

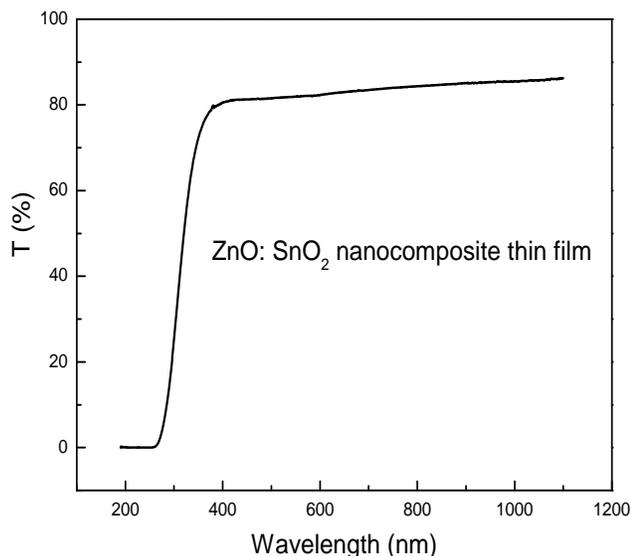


**Fig. 3.** Tauc plot of  $(\alpha hv)^2$  versus  $h\nu$  of SnO<sub>2</sub> thin film.

## Results and discussion

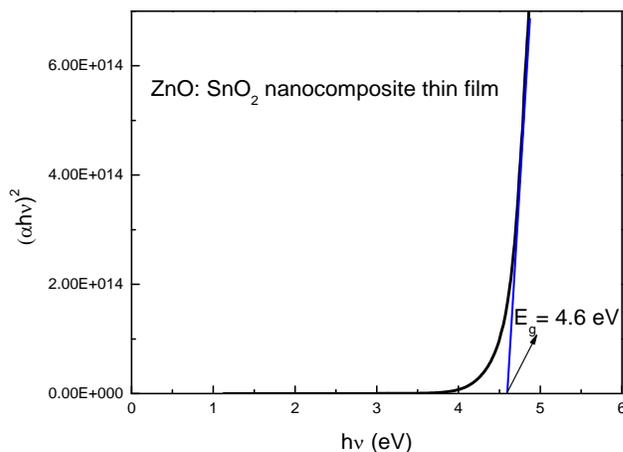
The optical transmission spectra of the as grown SnO<sub>2</sub> thin films (650 nm thin) deposited separately on corning glass substrate was measured in the wavelength range of 190 to 1100 nm, and the variation is shown in **Fig. 2**. SnO<sub>2</sub> thin film exhibits a high transmission (>40%) in the visible region and show a sharp fundamental absorption edge at around 340 nm.

Optical band gap of the SnO<sub>2</sub> thin film deposited on corning glass substrate, was calculated from the intercept on energy axis obtained by extrapolating the linear portion of the Tauc plot of  $(\alpha h\nu)^2$  vs photon energy ( $h\nu$ ) as shown in **Fig. 3**. Error in the determination of band gap value was less than 5%. Estimated value of band gap for as-grown SnO<sub>2</sub> thin film is found to be 4.55 eV and is close to the actual values for SnO<sub>2</sub> thin films (4.3 eV) grown by various techniques. Similarly the UV visible spectra of the as deposited ZnO:SnO<sub>2</sub> nanocomposite thin film is shown in **Fig. 4** having high transmission of >80% in the visible region. The value of bandgap (**Fig. 5**) increases slightly for ZnO:SnO<sub>2</sub> composite thin film with the incorporation of ZnO nanoparticles to 4.6 eV.

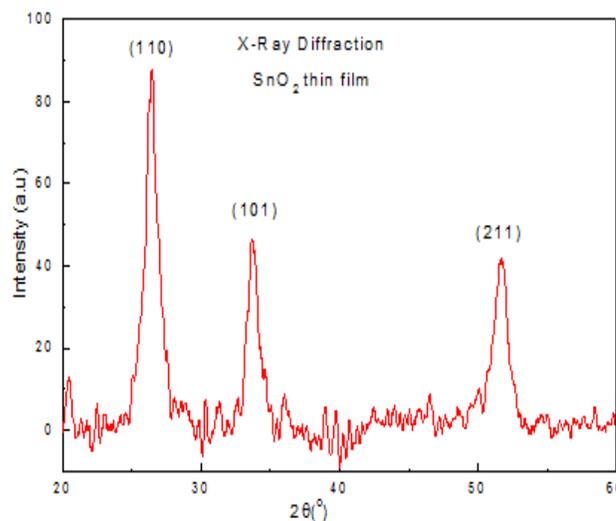


**Fig. 4.** Transmittance spectra of ZnO:SnO<sub>2</sub> nanocomposite thin film.

The as-grown SnO<sub>2</sub> and ZnO:SnO<sub>2</sub> nanocomposite thin films were found to be amorphous, and become nanocrystalline after a post deposition annealing treatment at 500 °C for 1 h in air. The annealed thin films were found to be smooth, transparent and strongly adherent to the substrate. **Fig. 6** shows the XRD pattern of SnO<sub>2</sub> thin film. Broad and well defined reflections corresponding to (110), (101) and (211) planes of SnO<sub>2</sub> were observed at 26.2°, 33.8° and 51.9° respectively for the deposited SnO<sub>2</sub> film and are in good agreement to the corresponding values reported for rutile structure [16]. The values of lattice constants ('a' and 'c') estimated from XRD data for the SnO<sub>2</sub> thin films are found to be 4.62 Å and 3.21 Å respectively. **Fig. 3** shows the XRD pattern obtained for the ZnO:SnO<sub>2</sub> composite thin film. It is observed that at 37.7° a hump is seen which corresponds to the (101) reflection plane of ZnO [26, 27].



**Fig. 5.** Tauc plot of  $(\alpha h\nu)^2$  versus  $h\nu$  of ZnO:SnO<sub>2</sub> nanocomposite thin film.



**Fig. 6.** X-Ray Diffraction of the SnO<sub>2</sub> thin film.

Using the Scherrer's formula the grain size of the deposited SnO<sub>2</sub> and ZnO:SnO<sub>2</sub> nanocomposite thin film was found to be ~9.8 nm and ~8.1 nm respectively which is contributing to higher surface to volume ratio beneficial for gas sensing application. Thus XRD studies shows that the SnO<sub>2</sub> thin film and ZnO: SnO<sub>2</sub> nanocomposite thin films deposited using sol-gel techniques are found to be nanocrystalline in nature.

AFM images of the SnO<sub>2</sub> and ZnO:SnO<sub>2</sub> nanocomposite sensor structures are shown in **Fig. 7**. The results show that the films are nanocrystalline with high surface roughness. Grain size is found to be reduced for the ZnO:SnO<sub>2</sub> nanocomposite thin film sensor structure with high roughness which are known to be important for obtaining enhanced gas sensing response characteristics [28].

**Fig. 8** shows the variation in resistance with time for SnO<sub>2</sub> thin film based sensor structure at an operating temperature of 70 °C towards 20 ppm NO<sub>2</sub> gas. When target gas (NO<sub>2</sub>) was inserted in the chamber, resistance of the film increases because of oxidizing behavior of NO<sub>2</sub> gas. SnO<sub>2</sub> responds to NO<sub>2</sub> gas in the following way [29].

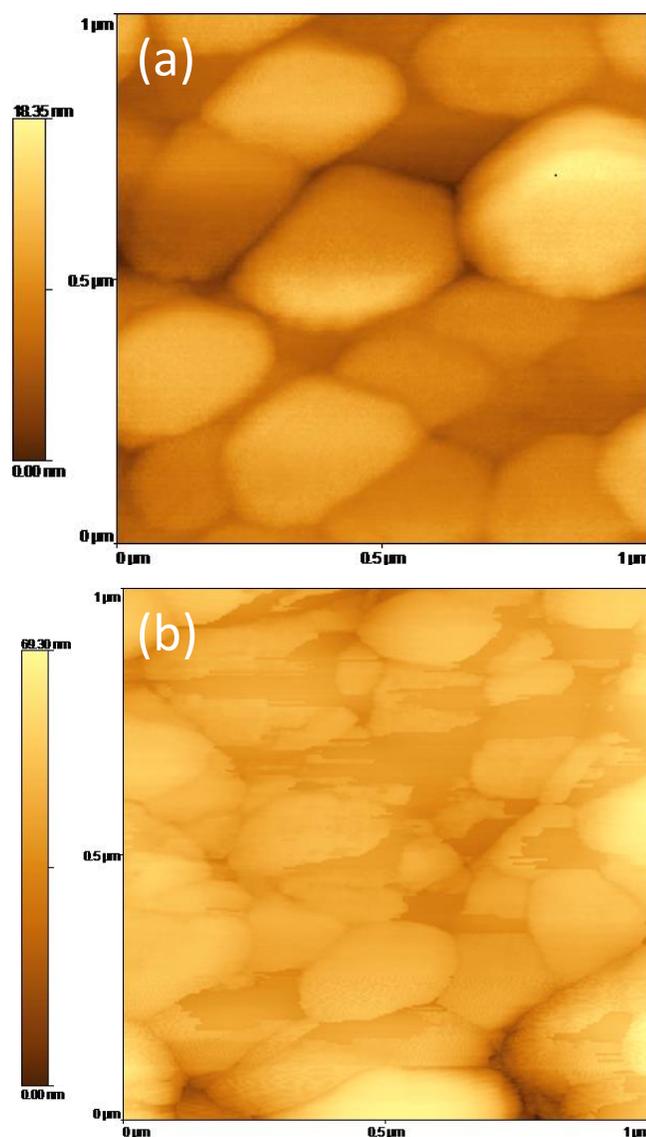
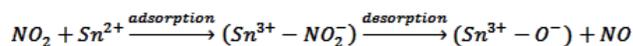


Fig. 7. Atomic force micrograph of (a) SnO<sub>2</sub> thin film (b) ZnO:SnO<sub>2</sub> thin film.

On the SnO<sub>2</sub> surface, NO<sub>2</sub> gas reacts with Sn sites and captures electrons resulting in decrease in conductivity thus increasing the resistance of the film. It can also be observed from Fig. 8 that the sensor shows a sensor response of 141 with slow response time of ~3 min when the target gas was inserted into the chamber and the sensor resistance recovers back in 7 min after flushing out the gas from the chamber.

Fig. 9 and 10 show the change in sensor resistance with time for the ZnO:SnO<sub>2</sub> nanocomposite sensor structure towards 20 ppm NO<sub>2</sub> gas at an operating temperature of 50 °C and 70 °C respectively. It can be observed from figures 9 and 10 that with the incorporation of ZnO nanoparticles in SnO<sub>2</sub> nanoparticles colloidal solution, the sensing

response has been increased to 621 and 727 at operating temperatures of 50 °C and 70 °C, respectively.

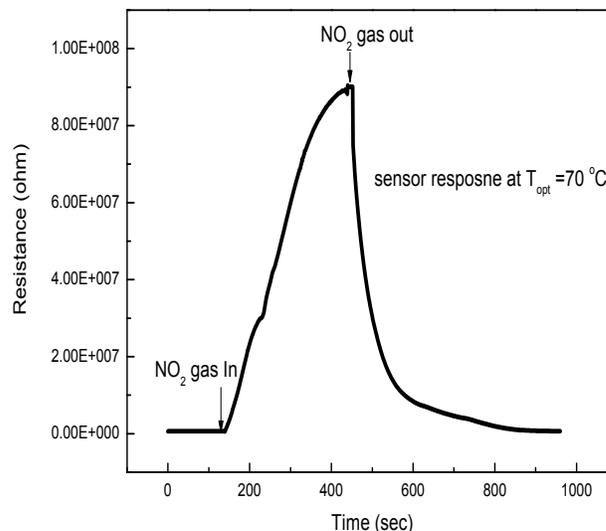


Fig. 8. Variation in resistance with time for SnO<sub>2</sub> thin film towards 20 ppm NO<sub>2</sub> gas.

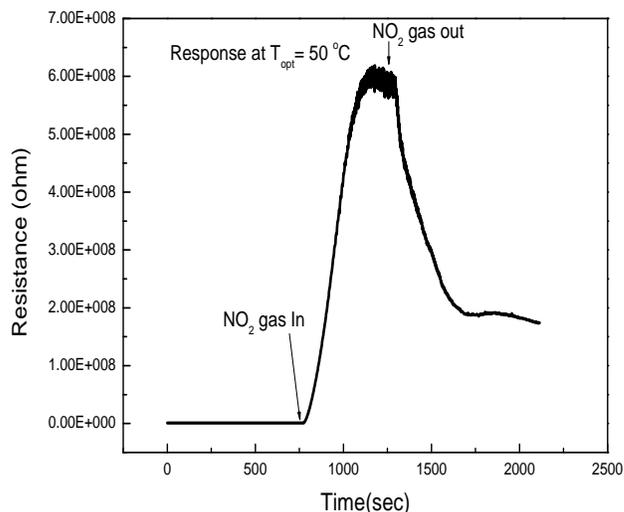
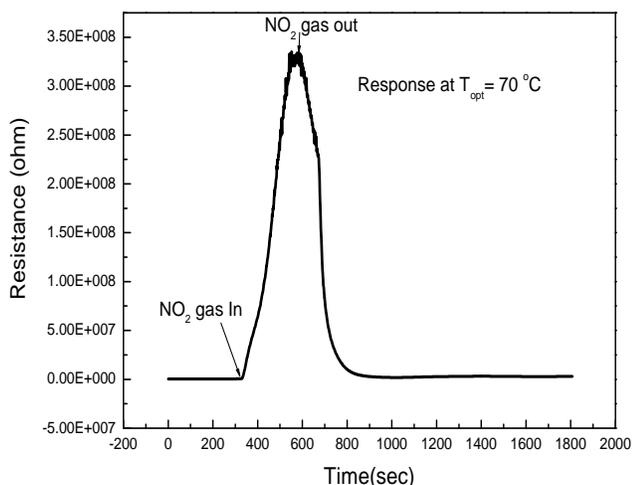
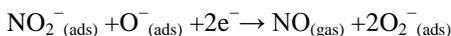
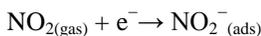


Fig. 9. Variation of resistance with time at 50 °C for ZnO: SnO<sub>2</sub> nanocomposite thin film towards 20 ppm NO<sub>2</sub> gas.

It can also be observed that at 50 °C the sensor did not recover back to its initial resistance while as at an operating temperature of 70 °C the sensor recovers back to its initial resistance. However, the response ( $t_{\text{res}}$ ) and recovery ( $t_{\text{rec}}$ ) times have not shown much improvement. The increased sensor response with the incorporation of ZnO may be attributed to the reduction in grain size as observed from AFM images (Fig. 7). The reduced grain size provides higher surface to volume ratio allowing more NO<sub>2</sub> gas molecules to react with the sensor surface. When NO<sub>2</sub> gas interacts with ZnO:SnO<sub>2</sub> surface, it interacts with SnO<sub>2</sub> in the same manner as mentioned earlier but when it interacts with ZnO surface it captures electrons from physisorbed oxygen species (O<sub>2</sub><sup>-</sup>) and gets desorbed as NO gas molecules even at lower operating temperatures [30].



**Fig. 10.** Variation of resistance with time at 70 °C for ZnO: SnO<sub>2</sub> nanocomposite thin film towards 20 ppm NO<sub>2</sub> gas.

Thus the number of reacting sites increases in the case of ZnO:SnO<sub>2</sub> surface in comparison to pure SnO<sub>2</sub> sensor surface. Thus even at lower operated temperature of 70 °C the sensor response is more in the case of ZnO: SnO<sub>2</sub> sensor (727) as compared to pure SnO<sub>2</sub> sensor (141). The results are promising for the fabrication of low temperature (<100 °C) operating NO<sub>2</sub> gas sensor. Besides the reduced grain size and increased surface roughness, the increased number of reacting sites due to the presence of ZnO in SnO<sub>2</sub> is responsible for the enhanced sensing response at an operating temperature of 70 °C.

## Conclusion

SnO<sub>2</sub> thin film and ZnO:SnO<sub>2</sub> nanocomposite thin film based sensor structure have been designed for the trace level (20 ppm) detection of NO<sub>2</sub> gas at low operating temperatures (<100 °C). ZnO:SnO<sub>2</sub> nanocomposite thin film based sensor response of about 727 at a low operating temperature of 70 °C with moderate response and recovery times. Nanoporous surface morphology having nanocrystalline grains are found to be important for obtaining enhanced response characteristics.

## Acknowledgements

The authors are thankful to Department of Science and Technology (DST), Department of Information Technology (DIT), NPMAS and University of Delhi for the financial support for carrying out this research work. One of the author (AS) is grateful to the Council of Scientific and Industrial Research (CSIR) for the research scholarship.

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